

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination DONDERO ET AL.	
		Examiner Satyanarayana R. Gudibande	Art Unit 1654	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	M	US-			

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	U	Beissert, et al., The Journal of Investigative Dermatology, 1998, 111, 609-615.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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